

中国认可 国际互认 检测 TESTING CNAS L4062



**TEST REPORT** 

Reference No	WTF23X10227081Y
Applicant	Mid Ocean Brands B.V.
Address	7/F., Kings Tower, 111 King Lam Street, Cheung Sha Wan, Kowloon, Hong Kong.
Manufacturer :	118144
Address	et and the and and and an at the ret ret
Product Name :	Solar TWS earbuds w carabiner
Model No	MO2177
Test specification	EN 50332-2:2013: Sound system equipment: Headphones and earphones associated with personal music players - Maximum sound pressure level measurement methodology Part 2: Matching of sets with headphones if either or both are offered separately, or are offered as one package equipment but with standardized connectors between the two allowing to combine components of different manufacturers or different design
Date of Receipt sample	
Date of Test	2023-11-01 to 2023-11-02
Date of Issue	2023-11-07
Test Report Form No	WTX_EN50332_2_2013A
Test Result	Pass At all and which which which

Remarks:

The results shown in this test report refer only to the sample(s) tested, this test report cannot be reproduced, except in full, without prior written permission of the company. The report would be invalid without specific stamp of test institute and the signatures of approver.

# Prepared By: Waltek Testing Group (Shenzhen) Co., Ltd.

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Tested by:

Ivan mang

Ivan Zhang

Approved by:

Harvid Wei



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Test item description	Solar TWS earbuds w carabiner
Trademark	ALL WALL AND AT A SECOND AND AND AND AND AND AND AND AND AND A
Model and/or type reference	MO2177
Rating(s)	DC5V/ 1.0A
Test Laboratory	Waltek Testing Group (Shenzhen) Co., Ltd.
Address	1/F., Room 101, Building 1, Hongwei Industrial Park, Liuxian 2nd
an an at the	Road, Block 70 Bao'an District, Shenzhen, Guangdong, China

General product information:

The sample(s) tested complies with the requirements of EN 50332-2: 2013.

**Model Differences:** 

N/A

#### Summary of testing:

All tests had been assessed for safety with respect to the above test specifications and found to comply with the requirements of the standards.



Test case verdicts	m. m.
Test case does not apply to the test object : N(N/A)	
Test item does meet the requirement: P(Pass)	
Test item does not meet the requirement: F(Fail)	
Degree of protection against moisture: IPX0	10 V
General remarks	A ILLE WIT
The test result presented in this report relate only to the object(s) tested.	20. 2.
This report shall not be reproduced, except in full, without the written approval of the Issuing t laboratory.	esting
The report would be invalid without specific stamp for test institute or the authority. The report would be invalid without the signatures of reporter and reviewer. "(see Enclosure #)" refers to additional information appended to the report. "(see appended table)" refers to a table appended to the report.	
Remark:	er unite wh
Whether parts of tests for the product have been subcontracted to other labs:	white white
If Yes, list the related test items and lab information: Test items:	
Lab information:	50



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111	EN 50332-2: 2013			
Clause	Requirement – Test	Result - Remark	Verdict	

4	Basic conditions for specifications and measurements (For basic conditions on measurements of the maximum sound pressure level, reference is made to EN 50332-1.)	
4.1	General description	Р
in whi The	The sound pressure level produced by headphones or earphones can be measured by subjective methods or by objective methods.	Р
Whitek	The reference method for evaluating the sound pressured level emitted by earphones is a psycho acoustic method known as "equal loudness" (EN60268-7)	P
4.2	Measuring principle	JUL BULL
A WALL	The standard is based on the use of a Head and Torso Simulator (HATS) in accordance with IEC 60318-7	P
WINLIFEK	The sound pressure level measured by the ear simulator microphone represents the pressure found at eardrum level and differs from that of the free field pressure by the HATS transfer function	Р

5	Player characteristics and methods of measure	ment	Р
5.1	Maximum output voltage Vm	a at at at a	×_N <sup>™</sup>
5.2	Method of measurement and conditions	which which where where	N
5.2.1	Input signal	the atter milet south	N N
inet wr	Actual musical signals are continuously fluctuating in both amplitude and spectral contents and thus cannot be used as test signals	outlet wonthet wonthet wonthet	N.S.
et white	The test signal must therefore be a stationary wide-band signal, the spectral content of which is representative of the musical signals.	aret would would would would	N
whitek w	The test signal used to determine the maximum sound pressure level of headphones shall be programme simulation noise, as defined in HD 483.1 S2.	MALTER MALTER WALTER WALTER	Ń
5.2.2	Operating conditions	at let set set	ST N N
L	- By a established power supply	it was an in a	N
MALIN	- tolerance of nominal supply voltage	let write white white whi	Ň
Whitek.	- All controls are adjusted to maximum sound pressure level	- Tet allet wiret wiret	N



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EN 50332-2: 2013				
Clause	Requirement – Test	Result - Remark	Verdict	
A	- load of player output	with the state	N	
5.2.3	Method of measurement for analogue audio outputs	white white white	N	
et art	The measuring equipment shall conform to: - EN 61672-1, class 1 for (sound level meters); - EN61260, class 1 for (1/3 octave analysers).	white white white w	N	
whitek	The maximum output voltage Vm shall be defined as unweithted r.m.s. voltage at the load, using an averaging time of 30 s or more.	A NUTER MALLER MALLER	N	
5.2.4	Method of measurement for digital audio outputs	a at at	N N	
inet unit	The maximum output level Lm shall be defined as average of digital signal, using an averaging time of 30 s or more.	white white white	N	
A NUTER	The digital input test signal is defined in EN 50332-1 as -10 dBFS.	ret ret stet with	A N C	

6	Headphone/Earphone characteristics and methods of measurement		N <sup>P</sup> P	
6.1	Measuring equipment	A 1 1 5	¢P	
iet uni	The measuring equipment shall be in accordance with EN 61672-1when connected with a HATS microphone.	The state while where	SU SU PL	
6.2	Simulated programme signal characteristic voltage	at alles alles while a	P	
6.3	Method of measurement arrangement and conditions	ster ster whet an	State State	
6.3.1	Input signal	with the the	P	
er m	- is program simulation noise as defined in HD 483.1 S2	ALTER WALTE WALT WALL	Р	
m	- according part 1, subclause 5.1	set while while while	Р	
6.3.2	Source impedance of analogue input devices	t at at at	P	
- Str.	- output impedance of the test signal source	when when some so	Р	
6.3.3	Acoustical measurement method	alifet milet walfer wat	р Р "V	
6.3.4	Headphones / earphones fit	in the state	P _	
, Mr *	- Position correctly for measuring maximum sound pressure	the world world world	Р	
m	- the manufacturer's instruction for correct use	Standing white white	Р	
6.3.5	Measure of evaluation	a to to	́. Р	



EN 50332-2: 2013				
Clause	Requirement – Test	Result - Remark	Verdict	
1. A.	- part 1, subclause 6.4	ma sur sur and	P	
men n	- sound pressure level reaches 94 dB SPL	LIP WALTER WALTE WALT	N/A	

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#### Table 2 – Classification of the characteristics to be specified

Subclause		Characteristics	Products	
5.4	1 500	Maximum output voltage	Player	
6.	1	Wide band characteristic voltage	Headphones	

# Measuring result:

5.1	Measuring result	N N N	
	SPL (dB)	Vmax (mV)	Criterion request(mV)
Left side	a start to the	NUTER MULTER WALTER WALTER W	NUL -MUL
Right side	and white white white	2 1 1 1 1 1 1	et wet -

6.3.5	Measuring result (SPL) (Part 1, 6.4)				с . Р . I
w cour	Measurement No.1	Measurement No.2	Measurement No.3	Measurement No.4	Measurement No.5
Left side	97.26	97.26	97.25	97.28	97.28
Right side	96.79	96.79	96.80	96.84	96.83
Average	Left side:97.27	A	Right side:96.81	S Contra of	un men n

6.3.5	Measuring result (WBCV)		N/April
	SPL (dB)	Vwbcv (mV)	Criterion request(mV)
Left side	94	E white white white	≥75
Right side	94	1 11- 11t .	≥75 √

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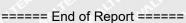
#### Photo Documentation Model: MO2177

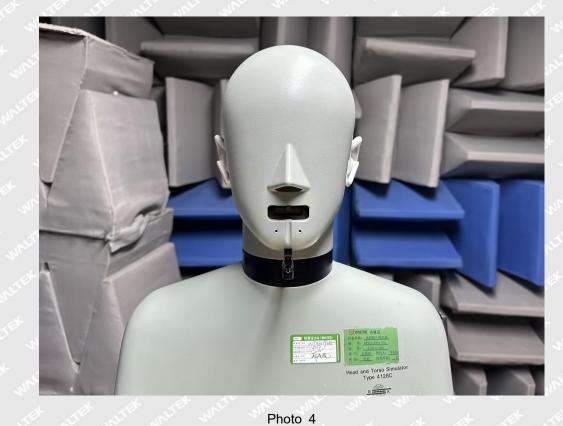


Photo 2

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